

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : 7,066,800 B2
APPLICATION NO. : 10/033732
DATED : June 27, 2006
INVENTOR(S) : Liang-Yuh Chen et al.

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

On Title Page

Item [56], References Cited, U.S. PATENT DOCUMENTS: Please include the following references:

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

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Notification of Transmittal of International Preliminary Examination Report
dated November 10, 2003 (4100 EP 02)

European Search Report for 03252801.0, dated January 16, 2004 (7047 EP).

Communication pursuant to Article 96(2) EPC for Application No. 02728965.4,
dated June 11, 2004 (4100 EP 02)

Copy of Search Report issued by the Austrian Patent Office for corresponding
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October 7, 2004.

Invitation to pay additional fees dated November 11, 2004 (4100 P5 PCT)

Notification of Transmittal of International Search Report and Written Opinion
dated February 21, 2005 (4100 PCT)

Notification of Transmittal of the International Search Report and Written
Opinion dated Marcy 14, 2005 (4100 P5 PCT)

PCT International Search Report and Written Opinion dated April 28, 2005 for
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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Alexander. Jr., "Electrically Conductive Polymer Nanocomposite Materials",
<http://www.afr1fhorizons.com/Briefs/Sept02/ML0206.html>, Date Unknown

Contolini, "Electrochemical Planarization of ULSI Copper," Solid State
Technology, Vol. 40, No. 6, June 1, 1997.

In the Drawings

Replace FIG. 2 with amended FIG. 2, copy attached

Column 4, Line 49: Before "inlet", change "a" to --an--

Column 6, Line 56: Change "electro polishing" to --electropolishing--

Column 9, Line 9: Change "aspects" to --aspect--

Column 9, Line 10: Change "comprises" to --comprise--

Column 10, Line 19: Before "article", change "a" to --an--

Column 11, Line 66: Before "article", change "a" to --an--

Column 14, Line 50: Change "perforation" to --perforations--

Column 15, Line 36: Change "10-cm" to --10 Ω -cm--

Column 15, Line 38: Change "1 -cm" to --1 Ω -cm--

Column 15, Line 61: Change "pas" to --pad--

Column 16, Line 45: Change "pas" to --pad--

Column 16, Line 57: Before "biasing", change "the" to --The--

Column 16, Line 60: Change "ploymer" to --polymer--

Column 18, Line 44: Change "discreet" to --discrete--

Column 19, Line 39: Change "shone" to --shown--

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Column 20, Line 14: After "pressure", delete "between"

Column 20, Line 29: Change "electro polishing" to --electropolishing--

Column 20, Line 31: Change "electro polishing" to --electropolishing--

Column 23, Line 30: After "urethane", change the comma to a period

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

In the Claims

Column 25, Claim 18, Line 65: Delete "conductive fillers include"

Column 26, Claim 24, Line 26: Change "and" to --or--

Column 26, Claim 25, Line 29: Change "and" to --or--

Column 26, Claim 29, Line 54: Delete "conductive fillers include"

Column 27, Claim 32, Line 3: After "least", insert --one--

Column 27, Claim 37, Lines 24-25: Delete "or combinations thereof"

Column 28, Claim 47, Line 10: Change "45" to --46--

Column 28, Claim 48, Line 13: Change "46" to --45--

Column 28, Claim 51, Line 32: Change "polycarbonete" to --polycarbonate--

Column 30, Claim 67, Line 9: After "article", delete "is"

Column 30, Claim 67, Line 18: After "surface", change the period to a semicolon

Signed and Sealed this

Twenty-first Day of November, 2006



JON W. DUDAS
Director of the United States Patent and Trademark Office

